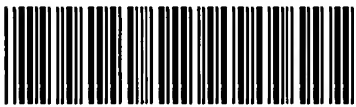


Search Notes 	Application/Control No. 10541994	Applicant(s)/Patent Under Reexamination HEIDE, PATRIC
	Examiner Chen, Shelley	Art Unit 3662

SEARCHED			
Class	Subclass	Date	Examiner
342	200	8/7/2007	SC

SEARCH NOTES		
Search Notes	Date	Examiner
PALM (inventor, IDS)	5/12/2007	SC
EAST (see search history)	5/12/2007	SC
EAST (see search history)	8/7/2007	SC

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner